

Pt. 29, App. E

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APPENDIX E TO PART 29—HIRF ENVIRONMENTS AND EQUIPMENT HIRF TEST LEVELS

This appendix specifies the HIRF environments and equipment HIRF test levels for electrical and electronic systems under § 29.1317. The field strength values for the HIRF environments and laboratory equipment HIRF test levels are expressed in root-mean-square units measured during the peak of the modulation cycle.

(a) HIRF environment I is specified in the following table:

TABLE I.—HIRF ENVIRONMENT I

Frequency	Field strength (volts/meter)	
	Peak	Average
10 kHz–2 MHz	50	50
2 MHz–30 MHz	100	100
30 MHz–100 MHz	50	50
100 MHz–400 MHz	100	100
400 MHz–700 MHz	700	50
700 MHz–1 GHz	700	100
1 GHz–2 GHz	2,000	200
2 GHz–6 GHz	3,000	200
6 GHz–8 GHz	1,000	200
8 GHz–12 GHz	3,000	300
12 GHz–18 GHz	2,000	200
18 GHz–40 GHz	600	200

In this table, the higher field strength applies at the frequency band edges.

(b) HIRF environment II is specified in the following table:

TABLE II.—HIRF ENVIRONMENT II

Frequency	Field strength (volts/meter)	
	Peak	Average
10 kHz–500 kHz	20	20
500 kHz–2 MHz	30	30
2 MHz–30 MHz	100	100
30 MHz–100 MHz	10	10
100 MHz–200 MHz	30	10
200 MHz–400 MHz	10	10
400 MHz–1 GHz	700	40
1 GHz–2 GHz	1,300	160
2 GHz–4 GHz	3,000	120
4 GHz–6 GHz	3,000	160
6 GHz–8 GHz	400	170
8 GHz–12 GHz	1,230	230
12 GHz–18 GHz	730	190
18 GHz–40 GHz	600	150

In this table, the higher field strength applies at the frequency band edges.

(c) HIRF environment III is specified in the following table:

TABLE III.—HIRF ENVIRONMENT III

Frequency	Field strength (volts/meter)	
	Peak	Average
10 kHz–100 kHz	150	150
100 kHz–400 MHz	200	200
400 MHz–700 MHz	730	200
700 MHz–1 GHz	1,400	240
1 GHz–2 GHz	5,000	250
2 GHz–4 GHz	6,000	490
4 GHz–6 GHz	7,200	400
6 GHz–8 GHz	1,100	170
8 GHz–12 GHz	5,000	330
12 GHz–18 GHz	2,000	330
18 GHz–40 GHz	1,000	420

In this table, the higher field strength applies at the frequency band edges.

(d) *Equipment HIRF Test Level 1.* (1) From 10 kilohertz (kHz) to 400 megahertz (MHz), use conducted susceptibility tests with continuous wave (CW) and 1 kHz square wave modulation with 90 percent depth or greater. The conducted susceptibility current must start at a minimum of 0.6 milliamperes (mA) at 10 kHz, increasing 20 decibel (dB) per frequency decade to a minimum of 30 mA at 500 kHz.

(2) From 500 kHz to 40 MHz, the conducted susceptibility current must be at least 30 mA.

(3) From 40 MHz to 400 MHz, use conducted susceptibility tests, starting at a minimum of 30 mA at 40 MHz, decreasing 20 dB per frequency decade to a minimum of 3 mA at 400 MHz.

(4) From 100 MHz to 400 MHz, use radiated susceptibility tests at a minimum of 20 volts per meter (V/m) peak with CW and 1 kHz square wave modulation with 90 percent depth or greater.

(5) From 400 MHz to 8 gigahertz (GHz), use radiated susceptibility tests at a minimum of 150 V/m peak with pulse modulation of 4 percent duty cycle with a 1 kHz pulse repetition frequency. This signal must be switched on and off at a rate of 1 Hz with a duty cycle of 50 percent.

(e) *Equipment HIRF Test Level 2.* Equipment HIRF test level 2 is HIRF environment II in table II of this appendix reduced by acceptable aircraft transfer function and attenuation curves. Testing must cover the frequency band of 10 kHz to 8 GHz.

(f) *Equipment HIRF Test Level 3.* (1) From 10 kHz to 400 MHz, use conducted susceptibility tests, starting at a minimum of 0.15 mA at 10 kHz, increasing 20 dB per frequency decade to a minimum of 7.5 mA at 500 kHz.

(2) From 500 kHz to 40 MHz, use conducted susceptibility tests at a minimum of 7.5 mA.

(3) From 40 MHz to 400 MHz, use conducted susceptibility tests, starting at a minimum of 7.5 mA at 40 MHz, decreasing 20 dB per frequency decade to a minimum of 0.75 mA at 400 MHz.